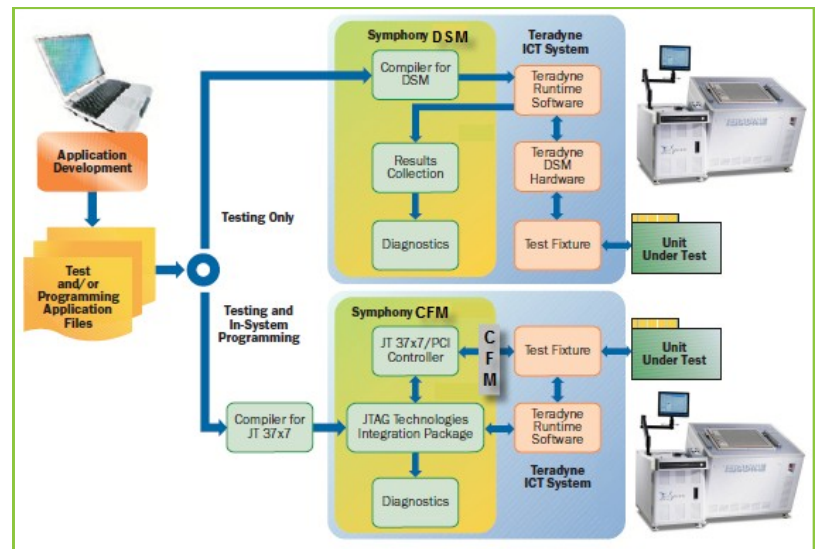


# Symphony Boundary Scan Solution

Advanced Boundary Scan Test Option for TestStation™

## KEY FEATURES

- Offline boundary scan programming and development capabilities
- Consolidation of test techniques in a single test platform
- Effective software only solution or high performance hardware option
- Integrates with Teradyne's Deep Serial Memory or Multi-Function Application Board
- Supports full range of IEEE 1149.1 tests
- Transportable boundary scan tests can be reUsed at other manufacturing stations
- Improved fault coverage and diagnostics
- Support for programming FLASH memories and CPLDs



For maximum flexibility Symphony supports both hardware and software implementations

## Optimal Test Strategy for Maximum Coverage

Symphony is an advanced boundary scan solution designed in partnership with JTAG Technologies for manufacturers using Teradyne's popular TestStation™ and legacy GR228X family of In-Circuit Test systems. Because boundary-scan and ICT are complementary test methodologies, this combination of test techniques provides an optimal test strategy with lowest overall cost and maximum fault coverage.

As shown in the Block Diagram above, there are two implementations of Symphony that are supported. **Symphony CFM** directly uses JTAG Technologies' boundary scan Controller and TAP Interface modules. The boundary scan controller is installed in a PCI slot of the TestStation's PC controller and it is cabled over to a JTAG Custom Function Module (CFM) that is installed on Teradyne's Custom Function Board (CFB). The CFB can plug into the accessory or pin board slot inside the ICT receiver bay. Specialized Teradyne test programming language for the CFB is utilized to control the relays that connect the boundary signals to the board under test.

**Symphony CFM** uses the same JTAG ProVision™ run time test execution software and test project files to control the JTAG hardware and run the boundary scan tests as is used by the standalone benchtop ProVision development solution. Developers who are familiar with JTAG's ProVision development environment will find it easy to use the **Symphony CFM** solution.

The second implementation, called **Symphony DSM**, is a software only solution that does not require any JTAG hardware to be installed in the in-circuit test system. The software consists of a JTAG-to-Teradyne boundary scan vector converter and a boundary scan diagnostic module. The software converter translates JTAG Technologies' boundary scan test vectors to Teradyne's native test programming language so they can be applied efficiently using Teradyne's Driver/Sensor and Deep Serial Memory in-circuit test instrumentation. If the boundary scan test vectors fail, the results are written to a file and interpreted by JTAG's boundary scan diagnostic software.

The JTAG Technologies' ProVision development tools support automatic generation of tests for the infrastructure, inter-connections, memory cluster interconnections and clusters of non-scan devices. In addition, the **Symphony CFM** solution has programming capabilities that can be utilized for those manufacturers who are interested in performing in-system programming of flash memory and CPLDs.

## Product Options:

Option	Description	Comment
Symphony TS / PC-17 / CFM	<p>Symphony CFM Package for TestStation and GR228X systems.</p> <p>Includes:</p> <ul style="list-style-type: none"> <li>• JT 3717 / PCI Controller</li> <li>• JT 2147 / CFM Custom Function Module w/1 TAP</li> <li>• JT 3717 / PCI</li> <li>• Execution software for testing and Flash/PLD programming</li> <li>• Result Collector and Bscan Diagnostics software</li> <li>• User Manuals</li> </ul>	<p>Additional JT 2147 / CFM modules can be added (up to 3) to support a max of 4 TAP ports.</p> <p>Requires one Teradyne Multi-Function Application Board - second board required if more than 2 JT 2147 / CFM modules are used.</p> <p>ProVision development software not included, can be purchased separately from JTAG Technologies.</p>
Symphony TS / DSM	<p>Symphony DSM Package for TestStation and GR228X systems.</p> <p>Includes:</p> <ul style="list-style-type: none"> <li>• JTAG to Teradyne test vector conversion software</li> <li>• Result Collector and Bscan Diagnostics software</li> <li>• User Manuals</li> </ul>	Requires Teradyne's Deep Serial Memory (DSM) option
Additional JT 2147 / CFM	Custom Function Module with 1 TAP	Optional - up to 4 TAP modules are supported (2 per CFB)
ProVision ProV_AST /N	ProVision Development Software licensed for test generation, debug, and diagnostic	Purchased separately through JTAG Technologies or their authorized distributors